
**Corrosion of metals and alloys —
Determination of the critical pitting
temperature under potentiostatic control**

*Corrosion des métaux et alliages — Détermination de la température
critique de piqûration des aciers inoxydables sous contrôle
potentiostatique*

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Contents

Page

Foreword	iv
Introduction	v
1 Scope	1
2 Normative references	1
3 Terms and definitions	1
4 Principle	1
5 Apparatus	2
6 Specimens	3
7 Calibration of specimen temperature vs. solution temperature	4
8 Procedure	4
9 Assessment of results	5
10 Test report	6
Annex A (informative) Guidelines for selecting the test parameters	7
Annex B (informative) Method of preventing a crevice attack	9
Annex C (informative) Potential difference of selected reference electrodes at 25 °C with respect to the standard hydrogen electrode (SHE)	13

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Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

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The main task of technical committees is to prepare International Standards. Draft International Standards adopted by the technical committees are circulated to the member bodies for voting. Publication as an International Standard requires approval by at least 75 % of the member bodies casting a vote.

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO shall not be held responsible for identifying any or all such patent rights.

ISO 17864 was prepared by Technical Committee ISO/TC 156, *Corrosion of metals and alloys*.

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Introduction

Stainless steel is susceptible to pitting corrosion, crevice corrosion, and stress-corrosion cracking, etc., although it is used as generally a corrosion-resistant material. Pitting phenomenon is generally of a random nature, therefore its measurement requires at least a couple of values. Critical pitting temperature defines the lowest potential-independent temperature, below which pitting does not occur.

The basic methodology was first standardized in ASTM G150, *Standard test method for electrochemical critical pitting temperature testing of stainless steels*.

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Corrosion of metals and alloys — Determination of the critical pitting temperature under potentiostatic control

1 Scope

This International Standard describes the procedure for determining the critical pitting temperature for stainless steels (austenitic, ferritic/austenitic, ferritic stainless steel) under potentiostatic control.

The principal advantage of the test is the rapidity with which the critical pitting temperature can be measured in a single test.

The critical pitting temperature, as determined in this International Standard, can be used as a relative index of performance, for example, to compare the relative performance of different grades of stainless steel. The test described in this International Standard is not intended to determine the temperature at which pitting will occur in service.

2 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 8044:1999, *Corrosion of metals and alloys — Basic terms and definitions*

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3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

3.1

critical pitting temperature

CPT

lowest temperature on the surface of the specimen at which stable propagating pitting occurs under specified test conditions

3.2

temperature ramp rate

rate at which the temperature of the surface of the specimen is increased during the test

NOTE The temperature ramp rate is expressed in degrees Celsius per second ($^{\circ}\text{C s}^{-1}$).

4 Principle

4.1 The test involves increasing the temperature of the surface of the specimen at a specified rate, whilst exposing the specimen to a specified environment and maintaining the potential of the specimen at a specified value. The temperature of the surface of the specimen is increased by heating the solution.

4.2 The critical pitting temperature is defined as the temperature of the specimen at which the current density exceeds a specified value for 60 s. A 60 s delay is used in order to ensure that the observed current increase originates from stable propagating pitting, and not short-lived current peaks originating from metastable pitting.

4.3 The specimen holder is designed to ensure that crevice corrosion does not occur at the seal between the specimen and the holder.

4.4 There may be a temperature gradient between the bulk of the solution and the surface of the specimen, the magnitude of which will depend on the geometry and dimensions of the specimen. Guidelines for calibrating the temperature of the surface of the specimen relative to the temperature of the solution are given in Clause 7.

4.5 The temperature ramp rate, environment and applied potential may be varied, depending on the material. Guidelines for selecting the test parameters for austenitic and duplex stainless steels are given in Annex A.

4.6 The critical pitting temperature is specific to the method of testing and should only be used as a comparative measure of performance.

5 Apparatus

5.1 Potentiostat

The potentiostat shall be capable of controlling the electrode potential to within ± 1 mV of a preset value.

5.2 Electrode potential-measuring instrument

The instrument should have a high impedance of the order of 10^{11} Ω to 10^{14} Ω , to minimize current drawn from the system during measurement. The sensitivity and accuracy of the instrument should be sufficient to detect a change of 1,0 mV.

5.3 Current-measuring instruments

The current in the circuit is evaluated from the potential drop measured across a known resistor. In many potentiostats, this measurement is made internally, but measurements can also be made externally by locating a resistor in the current line from the auxiliary electrode to the auxiliary connection on the potentiostat. The instrument shall be capable of measuring a current to within 2 % of the actual value.

5.4 Temperature controller

The temperature controller shall be capable of increasing the temperature of the surface of the specimen from 0 °C to 100 °C at a controlled rate. This is achieved by heating or cooling the solution. Above 10 °C, the average rate of temperature change of the specimen shall be controlled to within ± 30 % of the desired value, where the average is calculated over a temperature range of 10 °C. Guidelines for calculating the temperature of the specimen relative to the temperature of the solution are given in Clause 7.

5.5 Temperature-measurement instrumentation

The temperature-measurement instrumentation shall be capable of measuring the temperature of the test solution with an accuracy of $\pm 0,4$ °C.

5.6 Specimen holder

5.6.1 Any part of the specimen holder coming into contact with the test solution shall be made of an inert material.

5.6.2 The specimen holder shall be designed to ensure that crevice corrosion does not occur at the contact area between the specimen holder and the specimen. A method of preventing such crevice attack, using a flushed-port cell or a flushed specimen holder, is outlined in Annex B.

5.7 Test cell

5.7.1 The test cell shall contain the test specimen, a Luggin capillary probe connected to an external reference electrode for measuring the electrode potential, an auxiliary electrode, a port for insertion of a temperature-measuring device and a facility for stirring the solution in a repeatable manner. This can be achieved using a mechanical stirring device or simply by bubbling gas through the solution at a controlled rate.

5.7.2 A double-walled cell is commonly used to enable the solution to be cooled or heated by recirculating a liquid from an external heating bath to the outer chamber of the cell.

5.7.3 The tip of the Luggin capillary probe shall be positioned so that it is at a distance from the specimen of about, but not closer than, twice the diameter of the tip.

5.7.4 Any part of the test cell or specimen holder that comes into contact with the solution shall be constructed from an inert material. Polycarbonate, glass and polytetrafluoroethylene (PTFE) are suitable materials.

5.7.5 The ratio of the volume of solution in the test cell to the specimen area shall be at least 100 ml/cm².

5.8 Auxiliary electrode

The auxiliary electrode is commonly prepared from high-purity platinum. Other materials may be used provided they are inert. The auxiliary electrode may be constructed in the form of sheet or rod, or in the form of a gauze supported on a glass frame. The area of the auxiliary electrode should be at least the area of the specimen.

NOTE Graphite may be used as a auxiliary electrode but care must be taken to avoid contamination; desorption of species retained in the graphite may be necessary prior to use.

5.9 Reference electrode

5.9.1 The reference electrode shall be maintained at ambient temperature external to the test cell and connected to the test cell via a Luggin capillary probe.

5.9.2 Commonly used electrodes include the silver/silver chloride electrode and the saturated calomel electrode. The potentials of these electrodes at 25 °C relative to the standard hydrogen electrode at 25 °C are given in Annex C.

6 Specimens

6.1 Any specimen geometry compatible with the specimen holder may be used.

6.2 A minimum test area of 1 cm² shall be used.

6.3 The surface finish shall be reproducible.

7 Calibration of specimen temperature vs. solution temperature

7.1 There may be a temperature gradient between the bulk solution and the surface of the specimen. A test shall be conducted to calibrate the temperature of the specimen relative to the temperature of the solution. The calibration shall be performed using the procedure for the CPT test, given in Clause 8, except that no control or measurement of the electrode potential of the specimen is required.

7.2 The specimen size and geometry, solution volume, stirring rate and temperature ramp rate shall be the same for the calibration test as for the CPT test.

7.3 The specimen temperature shall be measured by installing a suitable temperature-measuring device inside the specimen, as close as possible (< 1 mm) to the surface of the specimen in contact with the solution. The temperature-measuring device shall be located at the centre of the specimen.

7.4 Calibration of the specimen temperature relative to the solution temperature shall be performed by taking measurements of the solution temperature and the corresponding specimen temperature, as the temperature of the bulk solution is increased at the temperature ramp rate. Measurements shall be taken at intervals of not more than 10 °C in the temperature range of interest.

7.5 The specimen-temperature calibration formula shall be calculated, based on a linear-order regression analysis.

7.6 The accuracy of the measurement of the temperature of the specimen based on the calibration data shall be $\pm 1,0$ °C.

8 Procedure

8.1 Preparation of reference electrodes

8.1.1 The difference in potential between the reference electrode and two other, validation, electrodes shall be measured. These electrodes shall be traceable to the standard hydrogen electrode and used and maintained solely for the purpose of validation. If the potential difference is greater than 3 mV, the test electrode shall be rejected.

8.1.2 The validation electrodes shall be stored in optimum conditions and regularly compared. If the potential difference between these varies by more than 1 mV, replacement shall be undertaken.

8.2 Preparation of specimen

8.2.1 The specimen shall be prepared to ensure a reproducible surface finish.

The time elapsed between grinding and immersion can have an influence on the subsequent pitting behaviour. The elapsed time selected will depend on the purpose of the test, but should be standardized for a particular set of tests. Little variation in surface film thickness occurs after 24 h, and hence a minimum elapsed time of 1 day is often useful.

8.2.2 The specimen shall be cleaned immediately prior to immersion in the solution by degreasing, rinsing in high-purity water (with a conductivity less than 1 $\mu\text{S}\cdot\text{cm}$), followed by ethanol or a similar solvent, and air drying. After degreasing, care shall be taken not to contaminate the test surface of the specimen.

8.3 Preparation of solution

8.3.1 The solution shall be prepared using reagent-grade chemicals and high-purity water.

8.3.2 Guidance on the selection of the solution for austenitic and other stainless steels is given in Annex A.